A precise mathematical model for charge thickness in ballistic carbon nanotube field impact semiconductors (CNTFETs)

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Abstract

Since the discovery of carbon nanotube (CNT), a great deal of groups pays more attention to it due to its unique properties. The theory of ballistic transport carbon nanotube field effect transistors (CNTFETs) is presented in the paper, and then a numerical model based on Newton-Raphson and linear approximation method for charge densities in CNTFET is proposed. The model could efficiently provide accurate solution to the self-consistent potential in a CNTFET, which is a function of parameters such as terminal voltages, CNT diameter, and Fermi level and so on. The model is simulated and the results show that compared with the piece-wise linear approximation, the numerical model in the paper is more accurate and efficient.

Keywords: Newton-Raphson method, ballistic carbon nanotube field effect transistors (CNTFETs), numerical model, self-consistent potential.

INTRODUCTION

Since the discovery of carbon nanotube (CNT) by Iijima in 1991 (McEuen, 2002), it has attracted more interests due to its unique electrical properties, such as reduced carrier scattering rate and high current carrying capability (Javey, 2003; Hichem, 2011; Pennington, 2005). And nowadays, a great deal of theoretical and experimental work has gone into understanding CNTs (Peng et al., 2006). CNTs are hollow seamless cylinders composed of one or more layers of graphene sheets (Paul, 2007; Guo, 2007; Vitusecich, 2010). Depending on their chirality, they can be either semiconducting or metallic. Semiconducting CNT has been used in the high performance field effect transistor (FET) as the channel nanotube (Paul, 2007).

The electronic properties of CNTFET have been studied in theory and experiment (Peng et al., 2006). Ungersbäck et al. (2003) simulated carrier transport in axial and lateral type CNTFETs and the simulation results show reasonable agreement with experimental data.

Dang et al. (2006) provided experimental data in detail and gave some compact models of CNTFETs. Deng et al. (2006) presented a circuit-compatible model of CNTFETs which can be simulated using HSPICE. The model can be well used in both digital and logic circuits (Liu, 2007). In their theory or simulation, the self-consistent potential is just approximately estimated, and they will not be in good agreement with experimental data when CNT parameters change. In other words, the device performance is a function of CNT parameters, such as diameter and length. To improve the device performance, Hashempour and Lombardi (2006) proposed a piece-wise linear approximation for self-consistent potentials in CNTFETs based on the ballistic transport theory. It can well accurately simulate CNTFETs, but the error between actual and modeled charge densities is a function of varied CNTFET parameters, such as CNT diameter and gate bias.

In order to effectively simplify the simulation of CNTFET, an accurate numerical model for charge density in CNTFETs is proposed in this paper based on ballistic transport theory (Dang, 2006; Hashempour and Lombardi, 2006; Rahman, 2003). The self-consistent potential of CNTFET is an important element in determining device current. So the more accurate self-consistent voltage compute, the less the error is. There are some advantage
features in the proposed numerical model. Firstly, it provides a more accurate numerical model of charge density in CNTFETs. Next, it uses Newton-Raphson and linear approximation method to efficiently and accurately compute the self-consistent voltage, and the result is more close to the actual. Lastly, the model can be used in general applications and be realized in HSPICE.

Theory of ballistic CNTFET

The drain current of CNTFET has been computed by means of the ballistic theory (Dang, 2006; Hashempour and Lombardi, 2006; Rahman, 2003; Grado-Caffaro, 2008)

\[
I_D = \frac{2q}{h} \int_{-\infty}^{\infty} T(E) f(E - E_F S) - f(E - E_F D) \, dE
\]

(1)

where \( q \) is the electron charge, \( h \) is Planck’s constant, \( T(E) \) is the trace of the transmission matrix and \( f(E) \) is the Fermi-Dirac occupation factor; \( E_{FS}, E_{FD} \) are the Fermi levels of the source and drain respectively, and \( E_F \) is the source-drain voltage.

Considering the first band contribution to the drain current, the drain current \( I_D \) can be formulated by

\[
I_D = \frac{4qkT}{h} \ln \left( 1 + \exp \left( -\frac{U_{SCF} - E_F}{kT} \right) \right) + \frac{q}{kT} \left( N(U_{SCF}) + qN(U_{SCF}) - qN \right)
\]

(2)

where \( T \) is the temperature, \( k \) is Boltzmann’s constant, and \( U_{SCF} \) is the self-consistent potential in the first band.

From the Equation (2), specifying \( V_{DS} \) and \( E_F \), the drain \( h \) is just a function of the self-consistent potential. And

\[
N = \frac{D_0}{e} \left( \frac{z^2 + 2 - i - E_F}{kT} \right) \exp \left( \frac{z^2 + 2 - i - E_F}{kT} \right)
\]

(4)

\[
N(U_{SCF}) = \frac{D_0}{2} \left( \frac{z^2 + 2 - i - E_F}{kT} \right) \exp \left( \frac{z^2 + 2 - i - E_F}{kT} \right)
\]

(5)

\[
N(U_{SCF}) = \frac{D_0}{2} \left( \frac{z^2 + 2 - i - E_F + qV}{kT} \right) \exp \left( \frac{z^2 + 2 - i - E_F + qV}{kT} \right)
\]

(6)

where \( q \) denotes the first conducting band potential.

\[ D_0 = \frac{8}{b} \]

where \( b \) is the carbon-carbon bond length, and

\[ b = 0.142 \text{nm}, \quad V_{H} = 3 \text{eV} \]

represents the carbon-carbon bond energy.

An accurate numerical model

Hamidreza and Lombardi (2006) proposed a piece-wise linear model for Equations (4) to (6), however when the parameters change, such as CNT, diameter is smaller than 1 nm, the error is close to 10%, the model is not good enough to evaluate the self-consistent potential. Here, a numerical model combined Newton-Raphson method with linear approximation is proposed. The model can efficiently and accurately solve the Equation (3) by using mix methods, and the error is very low. Equation (3) can be rewritten by

\[
F(x) = -q \left( a_G V_G + a_S V_S + a_D V_D \right) + qN(1) + \frac{q}{U_{SCF}} - qN(0) - x = 0
\]

(7)

The first step is to specify the initial self-consistent potential, such as \( U_{SCF}^0 \), and if \( F(U_{SCF}^0) = 0 \), the procedure is end with \( U_{SCF}^0 = U_{SCF}^0 \), or else go to the second step.

The second step is to modify the initial self-consistent potential \( U_{SCF}^0 \) by \( U_{SCF}^0 = U_{SCF}^0 + \frac{df}{dx} \). The increment \( U_{SCF} \) by means of Newton-Raphson method can be represented by

\[
U_{SCF}^1 = U_{SCF}^0 - \frac{df(U_{SCF}^0)}{dx}
\]

(8)

where \( \frac{df}{dx} \) is equated to \( \frac{q^2}{C} \left( \frac{dN_0}{dx} + \frac{dN_1}{dx} \right) - 1 \), and

\[
\frac{d}{dx} \left( \frac{dN_0}{dx} + \frac{dN_1}{dx} \right) - 1
\]
Figure 1. Integral function with different parameters.

\[
\frac{dN_1}{dx} = \frac{D_0}{2kT} \int_0^x f(z) \, dz
\]
\[
+ \frac{D_0}{2kT} \int_0^x \exp\left(\frac{\sqrt{z^2 + 1} - x - 1}{kT} - E\right) \, dz
\]
\[
= + \frac{D_0}{2kT} \int_0^x \frac{\exp\left(\frac{\sqrt{z^2 + 1} - x - 1}{kT} - E\right)}{(1 + \exp\left(\frac{\sqrt{z^2 + 1} - x - 1}{kT}\right))^2} \, dz
\]
\[
\frac{dN_2}{dx} = \frac{D_0}{2kT} \int_0^x f(z) \, dz
\]
\[
+ \frac{D_0}{2kT} \int_0^x \exp\left(\frac{\sqrt{z^2 + 1} - x - 1}{kT} - E\right) \, dz
\]
\[
= + \frac{D_0}{2kT} \int_0^x \frac{\exp\left(\frac{\sqrt{z^2 + 1} - x - 1}{kT} - E\right)}{(1 + \exp\left(\frac{\sqrt{z^2 + 1} - x - 1}{kT}\right))^2} \, dz
\]

Actually, Equations (9) and (10) are hard to get the numerical integral. Here, an area approximation is used to estimate the numerical value instead of integral. Figure 1 is the integral function of Equation 9 with different parameters. Their difference is just that the maximum value of the function in the left falls in the origin and in the right falls in other point. From Figure 1, it is known that the numerical integral of Equation 9 is just the approximative triangle’s area. And for Equation 9, the area can be represented by

\[
dN_1 = \frac{D_0}{2kT} (a b)
\]

where \(a\) is the width of the triangle, and \(b\) is the maximum value of the function. And \(b\) can be evaluated by

\[
b = \frac{f\left(z_m\right)}{kT} \text{ if } \left[x \leq E_F + 1, \text{ others}\right]
\]

Assume a measure of closeness as \(\varepsilon = 5 \times 10^{-5}\), then if \(f(x)\) is close to 0, we have the zero points. And \(a\) can be represented by

\[
a = \left(z - z_m\right) \text{ if } \left[x \leq E_F + 1, \text{ others}\right]
\]

\[
z = (kT \ln(k) + E + 1 - x)^2 + 2
\]
\[ z_2 = \sqrt{kT \ln (k_2 + E_F s + 1 - x) + \frac{1}{2} + \frac{1}{2}} \quad (16) \]

where \( k_1 \) and \( k_2 \) are the function of \( \varepsilon \) as

\[ k_1 = 1 - 2\varepsilon + \sqrt{4\varepsilon} \]

\[ k_2 = \frac{1 - 2\varepsilon - \sqrt{1 - 4\varepsilon}}{2\varepsilon} \quad (17) \]

From Equations (11) to (18), \( \frac{dN_1}{dx} \) can be approximately evaluated. And just replace \( E_F \) with \( E_F - qV_{DS} \) between Equations (11) and (18) to evaluate \( \frac{dN_2}{dx} \).

By Newton-Raphson method, the third step is to calculate \( F(U_{SCF}) \), and compare \( F(U_{SCF}) \) with a small number \( \xi \), such as \( \xi = 5 \times 10^{-4} \). If \( F(U_{SCF}) \) is smaller than \( \xi \), the procedure ends, or else go to the second step with \( U_{SCF} = \frac{1}{2}(U_{SCF}^{k-1} + U_{SCF}^{k-1}) \).

\[ U_{SCF}^{k+1} = 1 = \frac{U_{SCF}^{k-1} + U_{SCF}^{k-1}}{2} \]

\[ U_{SCF}^{k+1} = U_{SCF}^{k-1} - \frac{F(U_{SCF}^{k-1})}{\frac{dF}{du} U_{SCF}^{k-1}} \quad (19) \]

And when \( F(U_{SCF}) \) is smaller than \( \xi \), the iteration ends with \( U_{SCF}^{k+1} = U_{SCF}^{k-1} \).

**RESULTS AND DISCUSSION**

Here, the aforementioned numerical model will be simulated, and Hashempour and Lombardi (2006) proposal that a piece-wise linear model will also be modeled just to be compared with our model about performance. The simulation parameters are set as follows; the temperature is 300 K, CNT diameter is \( d = 1.4246 \text{nm} \), the source Fermi level \( E_F \) is set to \(-0.5\text{eV} \), and \( V_G = 0.8\text{V} \), \( V_{DS} = 0.8\text{V} \), \( \alpha_G = 0.45 / \text{d eV} \). From [17], \( a_G, a_S, a_D \) are0.87, 0.097, 0.033, respectively, and \( C_{tot} \) is 90 pF. Firstly, the graphic method is used to solve Equation 7. Figure 2 shows that the function \( F(U_{SCF}) \) varies with \( U_{SCF} \), and the answer of Equation 7 is the point where \( F(U_{SCF}) \) intersect with \( F = 0 \), as red circle in Figure 2. By using the graphic method, a close to actual answer could be gotten whose error is lower than \( 10^{-6} \), but it spends more time to get the answer, and the integral also needs more computer time. Figures 3 and 4 show the simulation results where ‘N-R’ and ‘P-W- L’ represent the Newton-Raphson method and piece-wise linear method, respectively. The relative error is the self-consistent potentials gotten from above methods compare with one.
from graphic method based on the same parameters. In Figure 3, the relative error of N-L method is close to zero whatever the source-drain voltage varies. However, the relative error of P-W-L method varies as the source-drain voltage changes and when $V_{DS} = -0.8\, V$, the relative error is top to 19.5%. In Figure 4, when CNT diameter is ranging from 0.4 to 3 nm, the relative error of N-L method is lower than $0.2 \times 10^{-4}$, while the relative error of P-W-L method almost achieves to 0.0017, which is remarkable bigger than N-L method’s. When CNT diameter belongs to the
range from 1 to 2 nm, the relative error of P-W-L method is lower than 0.001. From Figures 3 and 4, it can be concluded that the self-consistent potential is more accurate and efficient by using N-L method than by using P-W-L method.

**Conclusion**

In the paper, the theory of ballistic transport in CNTFETs is introduced and the charge density model is represented. In order to get the more accurate self-consistent potential efficiently, a numerical model is proposed by combining Newton-Raphson method with area approximation and is simulated. From simulation result, it indicates that the numerical model can accurately and efficiently evaluate the self-consistent potential of CNTFETs. With the development of EDA technology, the numerical model can be realized by using HSPICE.

**REFERENCES**


